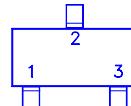
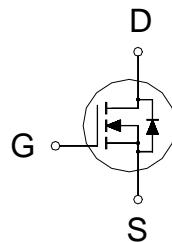


NIKO-SEM
**N-Channel Logic Level Enhancement
Mode Field Effect Transistor**
P01N02LMB
SOT-23 (M3)
PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
25V	180m Ω	1.2A


1. GATE
2. DRAIN
3. SOURCE
ABSOLUTE MAXIMUM RATINGS ($T_C = 25^\circ\text{C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Gate-Source Voltage	V_{GS}	± 15	V
Continuous Drain Current	I_D	1.2	A
		1.0	
Pulsed Drain Current ¹	I_{DM}	12	
Power Dissipation	P_D	0.6	W
		0.5	
Operating Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	
Lead Temperature (1/16" from case for 10 sec.)	T_L	275	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Case	$R_{\theta JC}$		65	
Junction-to-Ambient	$R_{\theta JA}$		230	°C / W

¹Pulse width limited by maximum junction temperature.
ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250 \mu\text{A}$	25			V
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$	0.7	1.0	2.5	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0V, V_{GS} = \pm 15V$			± 250	nA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = 20V, V_{GS} = 0V$			25	μA
		$V_{DS} = 20V, V_{GS} = 0V, T_J = 125^\circ\text{C}$			250	
On-State Drain Current ¹	$I_{D(\text{ON})}$	$V_{DS} = 10V, V_{GS} = 10V$	1.2			A
Drain-Source On-State Resistance ¹	$R_{DS(\text{ON})}$	$V_{GS} = 7V, I_D = 1.2A$		220	250	$\text{m}\Omega$
		$V_{GS} = 10V, I_D = 1.2A$		180	220	
Forward Transconductance ¹	g_{fs}	$V_{DS} = 20V, I_D = 1.2A$		16		S

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DYNAMIC						
Input Capacitance	C_{iss}	$V_{GS} = 0V, V_{DS} = 15V, f = 1MHz$		120		pF
Output Capacitance	C_{oss}			100		
Reverse Transfer Capacitance	C_{rss}			85		
Total Gate Charge ²	Q_g	$V_{DS} = 0.5V_{(BR)DSS}, V_{GS} = 10V,$ $I_D = 1A$		11		nC
Gate-Source Charge ²	Q_{gs}			3.0		
Gate-Drain Charge ²	Q_{gd}			5.8		
Turn-On Delay Time ²	$t_{d(on)}$			7		
Rise Time ²	t_r	$V_{DS} = 15V, R_L = 1\Omega$ $I_D \geq 1A, V_{GS} = 10V, R_{GS} = 50\Omega$		20		nS
Turn-Off Delay Time ²	$t_{d(off)}$			13		
Fall Time ²	t_f			19		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_c = 25^\circ C$)						
Continuous Current	I_S			1.2		A
Pulsed Current ³	I_{SM}			12		
Forward Voltage ¹	V_{SD}	$I_F = I_S, V_{GS} = 0V$			1.3	V
Reverse Recovery Time	t_{rr}	$I_F = I_S, dI_F/dt = 100A / \mu S$		70		nS
Reverse Recovery Charge	Q_{rr}			0.22		μC

¹Pulse test : Pulse Width $\leq 300 \mu sec$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Pulse width limited by maximum junction temperature.**REMARK: THE PRODUCT MARKED WITH "102B"**

SOT-23 (M3) MECHANICAL DATA

Dimension	mm			Dimension	mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A		0.95		H	0.10	0.15	0.25
B	2.60	2.80	3.00	I	0.37		
C	1.40	1.60	1.80	J			
D	2.70	2.90	3.10	K			
E	1.00	1.10	1.30	L			
F	0.00		0.10	M			
G	0.35	0.40	0.50	N			

